Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination YAMAOKA ET AL.		
10/812,983			
Examiner	Art Unit		
Hai H. Huyob	3747		

	SEARCHED				
Class	Subclass	Date	Examiner		
123	299	6/14/2005	ннн		
123	300	6/14/2005	ННН		
123	305	6/14/2005	ннн		
123	399	6/14/2005	ннн		
701	103-105	6/14/2005	ННН		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SE (INCLUDIN)	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
		DATE	EXMR
East		6/14/2005	ннн